# **MOSFET** – Power, P-Channel, D<sup>2</sup>PAK

-60 V, -18.5 A

#### **Features**

- Designed for Low R<sub>DS(on)</sub>
- Withstands High Energy in Avalanche and Commutation Modes
- AEC Q101 Qualified NTBV5605
- These Devices are Pb-Free and are RoHS Compliant

## **Applications**

- Power Supplies
- PWM Motor Control
- Converters
- Power Management

## **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	-60	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain Current (Note 1)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	-18.5	Α
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	88	W
Pulsed Drain Current	t <sub>p</sub> = 10 μs		I <sub>DM</sub>	-55	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 175	°C
Single Pulse Drain-to-Source Avalanche Energy (V <sub>DD</sub> = 25 V, V <sub>GS</sub> = 5.0 V, I <sub>PK</sub> = 15 A, L = 3.0 mH, R <sub>G</sub> = 25 $\Omega$ )			E <sub>AS</sub>	338	mJ
Lead Temperature for Soldering Purposes (1/8 in from case for 10 s)			TL	260	°C

## THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) - Steady State	$R_{\theta JC}$	1.7	°C/W

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. When surface mounted to an FR4 board using 1" pad size (Cu Área 1.127 in²).
- 2. When surface mounted to an FR4 board using the minimum recommended pad size (Cu Area 0.41 in<sup>2</sup>).

1

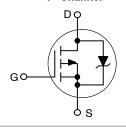


## ON Semiconductor®

## http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
-60 V	120 mΩ @ -5.0 V	–18.5 A

#### P-Channel

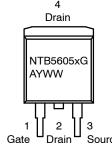


## **MARKING DIAGRAM & PIN ASSIGNMENT**





Х



= P or blank

= Assembly Location Α

= Year

WW = Work Week = Pb-Free Package

## **ORDERING INFORMATION**

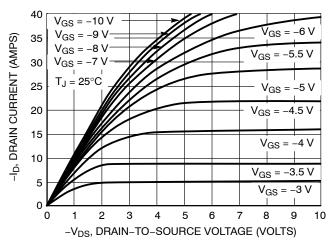
Device	Package	Shipping <sup>†</sup>
NTB5605PT4G	D <sup>2</sup> PAK (Pb-Free)	800 / Tape & Reel
NTBV5605T4G	D <sup>2</sup> PAK (Pb-Free)	800 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(Br)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(Br)DSS</sub> /T <sub>J</sub>				-64		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V	T <sub>J</sub> = 25°C			-1.0	μΑ
		V <sub>DS</sub> = -60 V	T <sub>J</sub> = 125°C			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{C}$	<sub>SS</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)						•	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS} = V_{DS}, I_{DS}$	<sub>)</sub> = -250 μA	-1.0	-1.5	-2.0	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>		V <sub>GS</sub> = -5.0 V, I <sub>D</sub> = -8.5 A V <sub>GS</sub> = -5.0 V, I <sub>D</sub> = -17 A		120 140	140	mΩ
Forward Transconductance	g <sub>FS</sub>	$V_{DS} = -10 \text{ V},$	I <sub>D</sub> = -8.5 A		12		S
Drain-to-Source On Voltage	V <sub>DS(on)</sub>	$V_{GS} = -5.0 \text{ V},$	I <sub>D</sub> = -8.5 A			-1.3	V
CHARGES, CAPACITANCES AND GATE	RESISTANCE	-					
Input Capacitance	C <sub>iss</sub>				730	1190	
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = V <sub>DS</sub> = -	= 1.0 MHz, -25 V		211	300	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	VDS = -23 V			67	120	
Total Gate Charge	$Q_{G(TOT)}$				13	22	
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = -5.0 \text{ V}, V_{DS} = -48 \text{ V},$ $I_{D} = -17 \text{ A}$			4.0		nC
Gate-to-Drain Charge	Q <sub>GD</sub>				7.0		
SWITCHING CHARACTERISTICS (Note 4	)	-					
Turn-On Delay Time	t <sub>d(on)</sub>				12.5	25	
Rise Time	t <sub>r</sub>	$V_{GS} = -5.0 \text{ V}, \text{ V}$	√nn = -30 V.		122	183	1
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = -17 \text{ A}, R_G = 9.1 \Omega$			29	58	ns -
Fall Time	t <sub>f</sub>				75	150	
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V	T <sub>J</sub> = 25°C		-1.55	-2.5	V
		I <sub>S</sub> = -17 A	T <sub>J</sub> = 125°C		-1.4		
Reverse Recovery Time	t <sub>rr</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = -17 \text{ A}$			60		
Charge Time	ta				39		ns
Discharge Time	t <sub>b</sub>				21		1
Reverse Recovery Charge	Q <sub>RR</sub>				0.14		nC

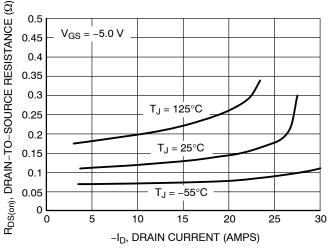
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.



 $V_{DS} = -10 \text{ V}$  $T_J = -55^{\circ}C$ -ID, DRAIN CURRENT (AMPS)  $T_J = 25^{\circ}C$ 30 = 125°C 20 10 0 6 2 3 4 5 9 -V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



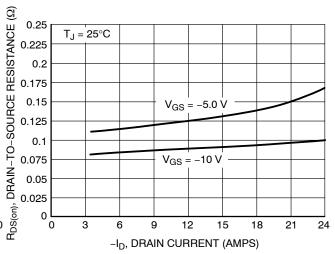
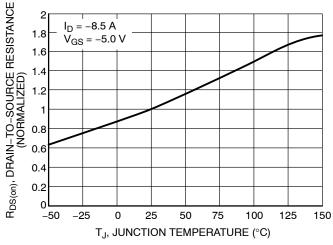


Figure 3. On-Resistance vs. Drain Current and Temperature

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



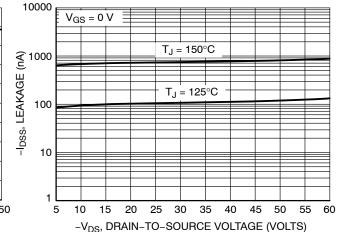


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

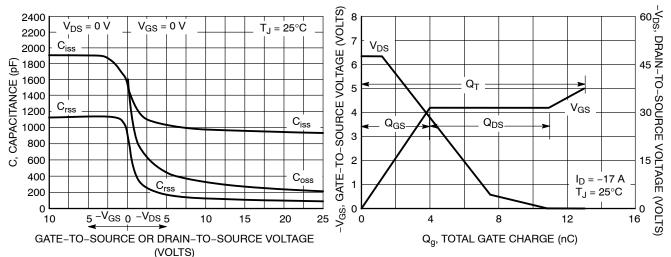


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

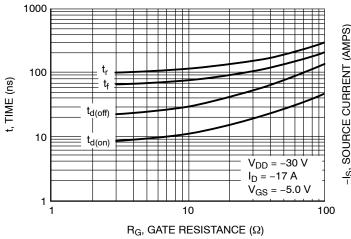


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

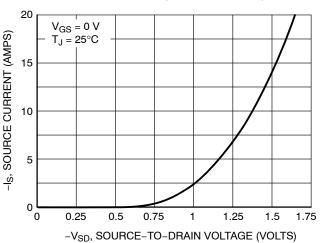


Figure 10. Diode Forward Voltage vs. Current

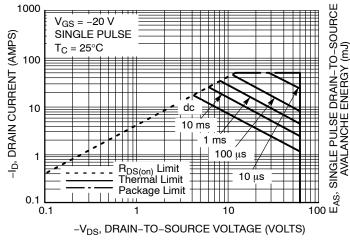


Figure 11. Maximum Rated Forward Biased Safe Operating Area

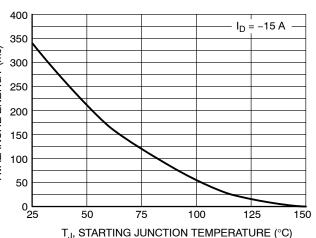


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

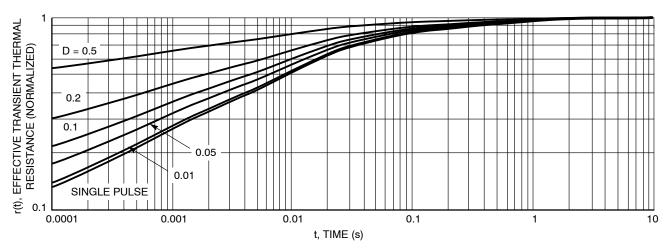


Figure 13. Thermal Response

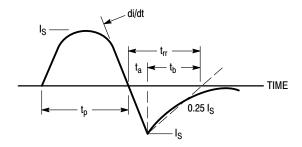
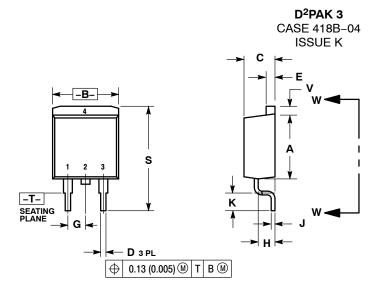


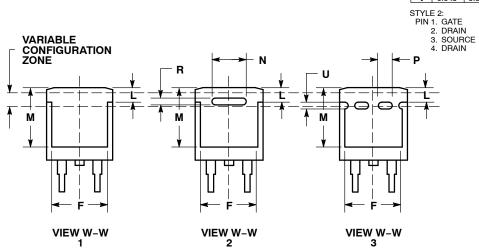
Figure 14. Diode Reverse Recovery Waveform

## **PACKAGE DIMENSIONS**

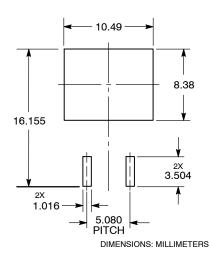


- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
  3. 418B-01 THRU 418B-03 OBSOLETE, NEW STANDARD 418B-04.

	INCHES		MILLIMETERS			
DIM	MIN	MAX	MIN	MAX		
Α	0.340	0.380	8.64	9.65		
В	0.380	0.405	9.65	10.29		
С	0.160	0.190	4.06	4.83		
D	0.020	0.035	0.51	0.89		
E	0.045	0.055	1.14	1.40		
F	0.310	0.350	7.87	8.89		
G	0.100 BSC		2.54 BSC			
Н	0.080	0.110	2.03	2.79		
J	0.018	0.025	0.46	0.64		
K	0.090	0.110	2.29	2.79		
L	0.052	0.072	1.32	1.83		
M	0.280	0.320	7.11	8.13		
N	0.197 REF		5.00 REF			
Р	0.079 REF		2.00 REF			
R	0.039 REF		0.99	9 REF		
S	0.575	0.625	14.60	15.88		
V	0.045	0.055	1.14	1.40		



## **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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